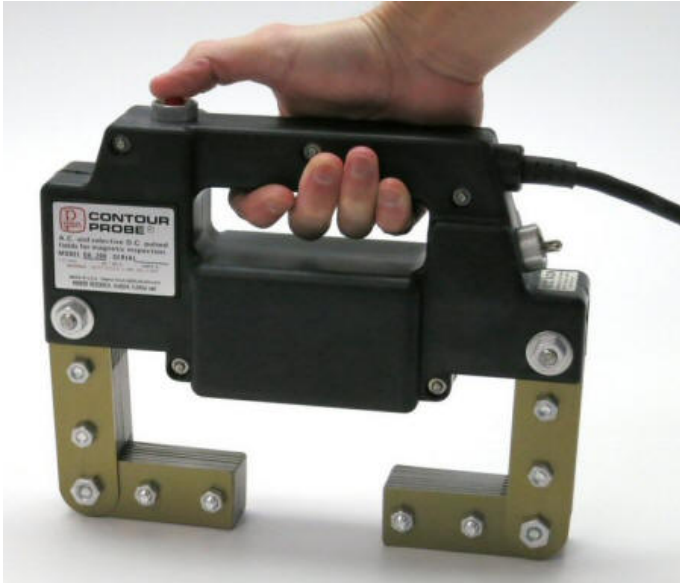


# DA-200 Series Contour Probes



- **Intense performance** in a rugged, reliable model
- Constant **AC or Half Wave Rectified DC** fields with the flip of a switch; for the location of surface and some sub-surface defects
- Apply continuous magnetic fields or demagnetize
- Use with dry powder, wet fluorescent or visible ink
- High impact-moulded housing
- One-year repair/replacement guarantee
- High capacity model

The **DA-200** Contour Probe is a portable, self-contained instrument designed to produce a magnetic field on or within ferrous-magnetic materials. The selective **AC and DC** functions are built into a single reliable instrument.

The AC mode produces an **intense AC field** for detection of surface defects and demagnetizing after inspection. The DC mode produces an intense Half Wave Rectified DC field for detection of some sub-surface defects. Combined with the flexibility of articulating legs and a rugged moulded housing, the Contour Probe can be used on nearly any part or surface contour in the lab, factory, or field site.

Your magnetic particle applications need the versatility and reliable performance advantages of the Parker Contour Probe. An industry standard with 45 years of NDT service.

## SPECIFICATIONS

	DA-200	DA-200S	A-210	A-210S
Physical	11 H x 10.75 L x 2.75 W			
Line Voltage Single Phase	115 VAC 50/60 Hz	230 VAC 50/60 Hz	115 VAC 50/60 Hz	230 VAC 50/60 Hz
Line Current	6 A AC/DC	4 A AC/DC	9.5 A AC	4 A AC
Duty Cycle	2 minutes on – 2 minutes off			
Weight	12 lbs (5.44 kg)			
Construction	Glass-filled nylon housing 10 foot (3 m) 3-wire power cord			
Span	18 in. (457 mm) across poles			
Field	AC/DC	AC/DC	AC	AC